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ON Semiconductor®

# FDMS8320L

# N-Channel PowerTrench<sup>®</sup> MOSFET 40 V, 248 A, 1.1 m $\Omega$

#### **Features**

- Max  $r_{DS(on)} = 1.1 \text{ m}\Omega$  at  $V_{GS} = 10 \text{ V}$ ,  $I_D = 32 \text{ A}$
- Max  $r_{DS(on)} = 1.5 \text{ m}\Omega$  at  $V_{GS} = 4.5 \text{ V}$ ,  $I_D = 27 \text{ A}$
- Advanced Package and Silicon combination for low r<sub>DS(on)</sub> and high efficiency
- Next generation enhanced body diode technology, engineered for soft recovery
- MSL1 robust package design
- 100% UIL tested
- RoHS Compliant

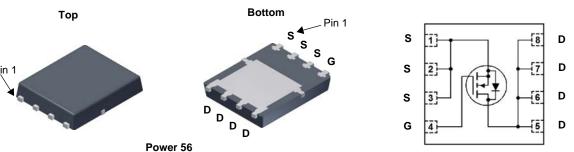


## **General Description**

This N-Channel MOSFET has been designed specifically to improve the overall efficiency and to minimize switch node ringing of DC/DC converters using either synchronous or conventional switching PWM controllers. It has been optimized for low gate charge, low  $r_{DS(on)}$ , fast switching speed ang body diode reverse recovery performance.

## **Applications**

- OringFET / Load Switching
- Synchronous Rectification
- DC-DC Conversion



## **MOSFET Maximum Ratings** T<sub>A</sub> = 25 °C unless otherwise noted.

Symbol	Paramo		Ratings	Units		
V <sub>DS</sub>	Drain to Source Voltage			40	V	
V <sub>GS</sub>	Gate to Source Voltage			±20	V	
	Drain Current -Continuous	T <sub>C</sub> = 25 °C	(Note 5)	248		
	-Continuous	T <sub>C</sub> = 100 °C	(Note 5)	157		
ID	-Continuous	T <sub>A</sub> = 25 °C	(Note 1a)	36	A	
	-Pulsed		(Note 4)	943		
E <sub>AS</sub>	Single Pulse Avalanche Energy		(Note 3)	264	mJ	
P <sub>D</sub>	Power Dissipation	T <sub>C</sub> = 25 °C		104	W	
	Power Dissipation	T <sub>A</sub> = 25 °C	(Note 1a)	2.5	VV	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Tempera	ature Range		-55 to +150	°C	

#### **Thermal Characteristics**

$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	1.2	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient (Note 1a	50	C/VV

#### **Package Marking and Ordering Information**

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMS8320L	FDMS8320L	Power 56	13 "	12 mm	3000 units

## **Electrical Characteristics** $T_J = 25$ °C unless otherwise noted.

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units	
Off Chara	Off Characteristics						
$BV_{DSS}$	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	40			V	
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	$I_D$ = 250 $\mu$ A, referenced to 25 °C		21		mV/°C	
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 32 V, V <sub>GS</sub> = 0 V			1	μΑ	
I <sub>GSS</sub>	Gate to Source Leakage Current	V <sub>GS</sub> = ±20 V, V <sub>DS</sub> = 0 V			100	nA	

#### On Characteristics

$V_{GS(th)}$	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$	1.0	1.7	3.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D$ = 250 $\mu$ A, referenced to 25 °C		-6		mV/°C
		V <sub>GS</sub> = 10 V, I <sub>D</sub> = 32 A		0.8	1.1	
r <sub>DS(on)</sub>	Static Drain to Source On Resistance	$V_{GS} = 4.5 \text{ V}, I_D = 27 \text{ A}$		1.0	1.5	mΩ
. ,		$V_{GS} = 10 \text{ V}, I_D = 32 \text{ A}, T_J = 125 ^{\circ}\text{C}$		1.2	1.7	
9 <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> = 5 V, I <sub>D</sub> = 32 A		206		S

#### **Dynamic Characteristics**

C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> = 20 V, V <sub>GS</sub> = 0 V, f = 1 MHz		8350	11110	pF
Coss	Output Capacitance			2840	3780	pF
C <sub>rss</sub>	Reverse Transfer Capacitance			169	295	pF
$R_g$	Gate Resistance		0.1	1.3	2.6	Ω

### **Switching Characteristics**

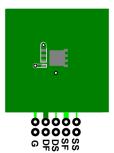
t <sub>d(on)</sub>	Turn-On Delay Time		17	30	ns
t <sub>r</sub>	Rise Time	V <sub>DD</sub> = 20 V, I <sub>D</sub> = 32 A,	19	35	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	$V_{GS} = 10 \text{ V}, R_{GEN} = 6 \Omega$	68	110	ns
t <sub>f</sub>	Fall Time		17	30	ns
$Q_g$	Total Gate Charge	V <sub>GS</sub> = 0 V to 10 V	121	170	nC
Qg	Total Gate Charge	$V_{GS} = 0 \text{ V to } 4.5 \text{ V} V_{DD} = 20 \text{ V},$	58	117	nC
Q <sub>gs</sub>	Gate to Source Charge	I <sub>D</sub> = 32 A	19.2		nC
Q <sub>gd</sub>	Gate to Drain "Miller" Charge		16.5		nC

#### **Drain-Source Diode Characteristics**

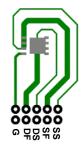
Is	Diode Continuous Forward Current	T <sub>C</sub> = 25 °C		248	Α
I <sub>s, pulse</sub>	Diode Pulse Current	T <sub>C</sub> = 25 °C		943	Α
V <sub>SD</sub>	Source to Drain Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_S = 2.1 \text{ A}$ (Note 2)	0.65	1.1	V
		$V_{GS} = 0 \text{ V}, I_S = 32 \text{ A}$ (Note 2)	0.74	1.2	
t <sub>rr</sub>	Reverse Recovery Time	I <sub>F</sub> = 32 A, di/dt = 100 A/μs	68	108	ns
Q <sub>rr</sub>	Reverse Recovery Charge	I <sub>F</sub> = 32 A, αι/αι = 100 A/μs	59	95	nC
t <sub>rr</sub>	Reverse Recovery Time	1 - 32 A di/dt - 300 A/	53	85	ns
Q <sub>rr</sub>	Reverse Recovery Charge	$I_F = 32 \text{ A, di/dt} = 300 \text{ A/}\mu\text{s}$	104	167	nC

Notes:

<sup>1.</sup> R<sub>0JA</sub> is determined with the device mounted on a 1 in<sup>2</sup> pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R<sub>0CA</sub> is determined by the user's board design.



a) 50 °C/W when mounted on a 1 in² pad of 2 oz copper



 b) 125 °C/W when mounted on a minimum pad of 2 oz copper.

- 2. Pulse Test: Pulse Width < 300  $\mu$ s, Duty cycle < 2.0%.
- 3. Starting  $T_J$  = 25 °C; N-ch: L = 0.3 mH,  $I_{AS}$  = 42 A,  $V_{DD}$  = 36 V,  $V_{GS}$  = 10 V.
- 4. Pulsed Id please refer to Fig 11 SOA graph for more details.
- 5. Computed continuous current limited to Max Junction Temperature only, actual continuous current will be limited by thermal & electro-mechanical application board design.

## **Typical Characteristics** $T_J = 25$ °C unless otherwise noted.

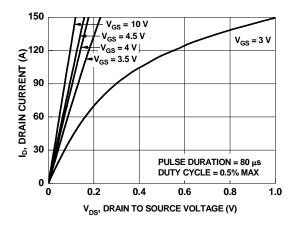


Figure 1. On Region Characteristics

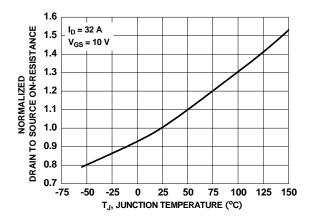


Figure 3. Normalized On Resistance vs. Junction Temperature

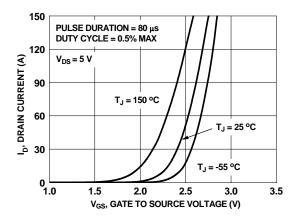


Figure 5. Transfer Characteristics

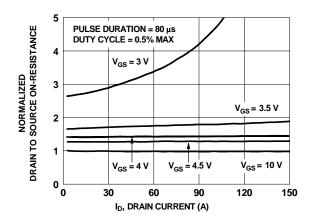


Figure 2. Normalized On-Resistance vs. Drain Current and Gate Voltage

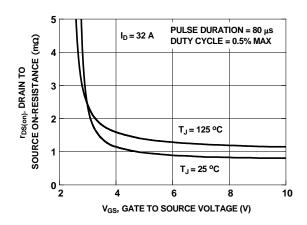


Figure 4. On-Resistance vs. Gate to Source Voltage

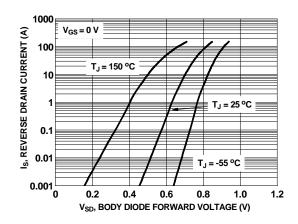


Figure 6. Source to Drain Diode Forward Voltage vs. Source Current

## **Typical Characteristics** $T_J = 25$ °C unless otherwise noted.

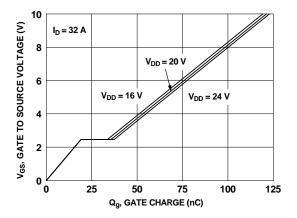


Figure 7. Gate Charge Characteristics

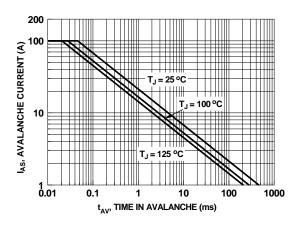


Figure 9. Unclamped Inductive Switching Capability

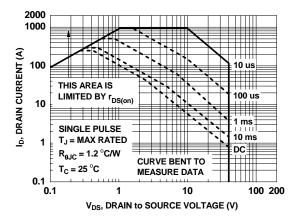


Figure 11. Forward Bias Safe Operating Area

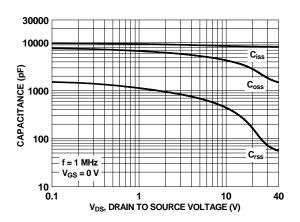


Figure 8. Capacitance vs. Drain to Source Voltage

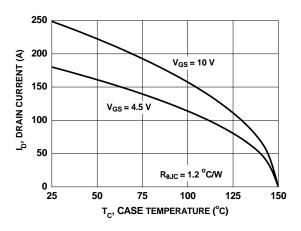


Figure 10. Maximum Continuous Drain Current vs. Case Temperature

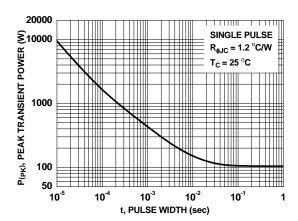


Figure 12. Single Pulse Maximum Power Dissipation



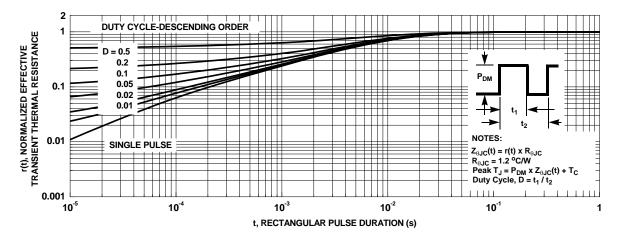


Figure 13. Transient Thermal Response Curve

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